Search Notes (continued)

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,619	LIU, JIAN	
Examiner	**Art Unit**	
Mark Hellner	3663	

SEARCHED			
Class	Subclass	Date	Examiner
359	333 341.1 341.32	8/8/05	MH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR